

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10751327	ZHANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Karen E Toth	3735

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
205	775, 777.5	2/28/2008	ket
600	309-367	2/28/2008	ket

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched EAST (USPAT, USPGPUB)	2/28/2008	ket
PALM inventor name search	2/28/2008	ket
class/subclass and keyword search	2/28/2008	ket
see attached		

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
all	calibrat\$3 and sensor and (data array curve) and (nominal initial original) and (adjust\$4 shift\$3) and (linear adj regression) and point	2/28/2008	ket